NOTES:

1. SUBSTRATE:

Silicon (Si)

2. CENTERING TOLERANCE:

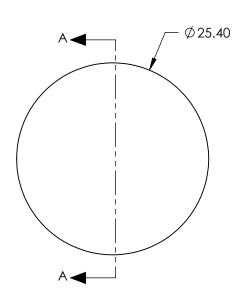
EDGE THICKNESS VARIATION: <20µm

3. COATING (APPLY ACROSS CLEAR APERTURE)

\$1&\$2: R(AVG) <0.5% @ 3 - 5µm R(ABS) <1.5% @ 3 - 5µm



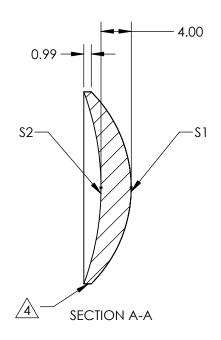
5. SURFACE ROUGNESS: <100 Ra



ALL DIMS IN

mm

DWG NO



DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

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	\$1	S2	
SHAPE	CONVEX	CONCAVE	
RADIUS	18.00	36.49	
SURFACE QUALITY	60-40	60-40	
CLEAR APERTURE	ø22.86	ø22.86	
IRREGULARITY AT 632.8nm	λ/4	λ/4	
BEVEL	PROTECTED AS NEEDED	PROTECTED AS NEEDED	

	Edmund Optics®
1	OF Amon Did v 10 7mm El 2 Eum DDAD

_	THIRD ANGLE PROJECTION	$\Diamond \lhd$	TITLE	25.4mm Dia. x 12.7mm FL, 3 - 5µm BE Coated, ISP Optics Silicon (Si) Aspheric	
_	ALL DIMS IN	mm	DWG NO	0.400.4	SHEET

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